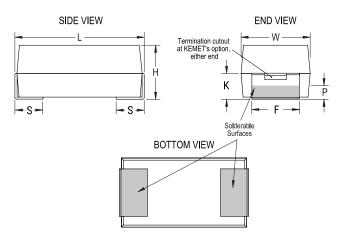


CWR11JH105KCB

Aliases (T492A105K020CH4251, T492A105K020CS4251)

T492 CWR11, Tantalum, MnO2 Tantalum, Military/High Reliability, 1 uF, 10%, 20 VDC, SMD, MnO2, Molded, Military Equivalent, C (0.01%/1000 Hrs), 10 Ohms, 1.8 mm, 0.8 mm, 1206 / 3216



Click	here	for	the	ЗD	model.
CIICK	nere	101	uie	$^{\circ}$	model.

General Information	
Series	T492 CWR11
Dielectric	MnO2 Tantalum
Style	SMD Chip
Description	SMD, MnO2, Molded, Military Equivalent
RoHS	No
Prop 65	WARNING: Cancer and reproductive harm - https://www.p65warnings.ca.gov / .
SCIP Number	1dd2e1b8-26dd-4d52-927c-6f9d 519011aa
Termination	Tin Lead (SnPb)
0 110	
Qualifications	MIL-PRF-55365/8, CWR11 Style
AEC-Q200	MIL-PRF-55365/8, CWR11 Style No
	·
AEC-Q200	No

Dimensions	
L	3.2mm +/-0.2mm
W	1.6mm +/-0.2mm
Н	1.6mm +/-0.2mm
T	0.13mm REF
S	0.8mm +/-0.3mm
F	1.2mm +/-0.1mm
В	0.4mm +/-0.15mm
E	1.3mm REF
G	1.1mm REF
K	0.7mm MIN
Р	0.35mm MIN
R	0.4mm REF
X	0.1mm +/-0.1mm REF

Packaging Specifications	
Packaging	T&R, 178mm
Packaging Quantity	2000

Specifications	
Capacitance	1uF
Tolerance	10%
Voltage DC	20 VDC (85C), 13.4 VDC (125C)
Temperature Range	-55/+125°C
Rated Temperature	85°C
Dissipation Factor	4% 120Hz 25C
Failure Rate	C (0.01%/1000 Hrs)
ESR	10 Ohms (100kHz 25C)
Ripple Current	87 mA (rms, 100kHz 25C)
Leakage Current	0.5 uA (5min 25°C)
Testing and Reliability	Surge Testing (10 Cycles At -55C And +85C After Weibull)

Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute - and we specifically disclaim - any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by us with reference to the use of our products is given gratis, and we assume no obligation or liability for the advice given or results obtained.

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